

**Notice of References Cited**

Application/Control No.

09/916,273

Applicant(s)/Patent Under  
Reexamination  
TAKANO ET AL.

Examiner

Joon H. Hwang

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	EP 0851368 A2	01-1998		Jakob et al.	G06F 17/30
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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